

CONTENTS

CONTRIBUTORS vii
PREFACE ix
FUTURE CONTRIBUTIONS xi

Scanning Nonlinear Dielectric Microscopy
YASUO CHO

I. Introduction 2
II. Principle and Theory for SNDM 3
III. Quantitative Measurement 17
IV. Higher-Order Nonlinear Dielectric Microscopy 30
V. Three-Dimensional Measurement Technique 37
VI. Application of SNDM Technique for High-Performance
Ferroelectric Material and Devices 41
VII. Conclusion 54
References 55

High-Order Accurate Methods in Time-Domain Computational
Electromagnetics: A Review
J. S. HESTHAVEN

I. Introduction 59
II. Maxwell's Equations in the Time Domain 63
III. Case for High-Order Methods in Computational
Electromagnetics 67
IV. High-Order Finite Difference Schemes 70
V. Spectral Methods 84
VI. High-Order Finite Volume Schemes 94
VII. Finite Element Schemes 97
VIII. Issues in Temporal Integration 113
IX. Conclusions and Outlook 115
References 117

**Prefiltering for Pattern Recognition Using Wavelet Transform
and Neural Networks**

FAN YANG AND MICHEL PAINDAVOINE

I. Introduction	126
II. Introduction to Neural Networks	127
III. Introduction to Wavelet Transform	147
IV. Pattern Recognition Using Wavelet and Neural Network for Signal and Image Processing Applications	158
V. Wavelet Prefiltering Technique Applied to Handwriting Movement Analysis and Face Recognition	177
Appendix	199
References	201

**Electron Optics and Electron Microscopy: Conference
Proceedings and Abstracts as Source Material**

P. W. HAWKES

I. Introduction	209
II. International Congresses (ICEM)	214
III. Regional Congresses	217
IV. National Conferences	222
V. Thematic meetings	326
VI. Acknowledgements	353
VII. Acronyms	358
References	361
INDEX	381